PSNN-2014-0869

Group(担当部門名):	Second Electrical	System Design &
	Engineering Gr.	
Approved by (承認)	Reviewed by (調査)	Prepared by (作成)
N. Oda	N. Oda	T. Hayashi
Sept. 28, 2017	Sept. 28, 2017	Sept. 28, 2017

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
1	5	1. Introduction	Qualification Test summary Report Revision 2 incorporates the following:  - Correction of minor errors  - Correction of Figure of APPENDIX A and B	[None]	None	Clarify what were revised in this revision.	Not required.
2	9	2.4. Modifications	The Hardware configuration was changed during the environmental test <u>after a</u> Test System failure caused by incorrect operation of the environmental chamber, <u>where water condensing</u> on the top of the <u>chamber fell</u> into the powered electronics.	The Hardware configuration was changed during the environmental test due Test System failure caused by incorrect operation of the environmental chamber, condensing water on the top of the chamber that fell into the powered electronics.	None	Wording correction for betterment.	Not required.
3	16	3.3.5.2 Performance Requirements	The ESD was applied to the test points which can be touched by persons during normal operation and the points that can be touched with maintenance personnel with wristband under the administrative permission during maintenance as a special case.	The ESD was applied to the test points which can be touched by persons during normal operation.	None	Clarify the test points.	Not required.
4	22	5. Test Procedure	The initial tests were performed for the assembled Test System in Japan.	Initial tests were performed for the assembled Test System in Japan.	None	Wording correction.	Not required.
5	23	5. Test Procedure	The sequence of tests is shown in Table 5-1 (a). (b) and Figure 5-1 below. Table 5-1 (a) list the Reference page in the ERS. Test procedure document number and the Test Lab test procedure number. Table 5-1 (b) the contents of the Operability Test and the Prudency Test of the PRM.	The sequence of tests is shown in Table 5·1 and Figure 5· <u>5</u> below.	None	Table 5-1 (b) is added.	Not required.
6	24	5. Test Procedure	Table 5-1 Qualification Test Overview (a)	Table 5-1 Qualification Test Overview	None	Addition of the table sub-number "(a)."	Not required.

Job No.	DCN No.	Rev. No.	Doc. Title. No. and Rev. No.	1 1 / 22
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2	sh- 1 / 33

No.	Page	Item (改訂内容)		Current 変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
7	25	5. Test Procedure	Pro-Customer har freeze frame of the customer frame fr	Consumer has Property had Consumer Cons	「None」	III	Table 5-1 (b) is added.	See DVR-E2-201 70928

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.	
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2	

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
8	26	5. Test Procedure	The Operability Test and the Prudency Test conducted in the Pre-Qualification Test and the Post-Qualification Test and the Post-Qualification Test (After re-replacement of modules) include following Tests.  Operability Test:  (1) Linearity test for APRM level. TPM level and LPRM level at the LPRM gains 40µA/100%  (2) Linearity test for APRM level. TPM level and LPRM level at the LPRM gains 400µA/100%  (3) Linearity test for APRM level. TPM level. and LPRM level at the LPRM gains 400µA/100%  (4) APRM Upscale (High-High) trip and TPM Upscale trip response time test at the LPRM gains 40µA/100%  (5) APRM Upscale (High-High) trip and TPM Upscale trip response time test at the LPRM gains 2400µA/100%  (6) APRM Upscale trip response time test at the LPRM gains 2400µA/100%  (7) Linearity test for FLOW level  (8) APRM Inoperable trip function test  (9) DI function test  (10) Low voltage power supply failure test for LPRM unit  (11) Low voltage power supply failure test for FLOW unit  (13) Watchdog function test for LPRM unit	[None]	III	Note for Table 5-1 (b) are added.	See DVR-E2-201 70928

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
			(14) Watchdog function test for LPRM/APRM unit (15) Watchdog function test for FLOW unit (16) Current value test of Square Root module in FLOW unit (17) Loss of power test (18) Power interruption test Prudency Test (19) DI Toggling test				
	(	Continued	(21) Failure simulation test  Note 1: Toshiba did not conduct			Continued	
			(1).(3).(4).(6).(8).(10).(11).(12).(13).(14).(15).  Note 2: Toshiba did not conduct (2).(3).(13).(14).(15).(16). but Toshiba conducted watchdog timer function test for the LPRM module inserted Slot1 of LPRM and LPRM/APRM units.  Note 3: Toshiba did not conduct (21).				
9	33	5.4.3.1.Low-Frequency Conducted Emissions	The frequency range was from <u>60</u> Hz to 10 kHz.	The frequency range was from $\underline{120}$ Hz to $10~\mathrm{kHz}$ .	None	Error correction	Not required.

	The second secon		
Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
10	48-50	6.3.2.Data Evaluation (1)Resonance Search	Figures A.1.1 through A.1.15 shows the results for the resonance search along vertical axis. Figures A.1.1, A.1.6, and A.1.11 are the spectra of the test fixtures.  Toshiba performed resonance searches in accordance with IEEE Std. 344·1987. Toshiba understands that the seismic tests based on IEEE Std. 344·1987 also satisfy IEEE Std. 344·2987 (and Section 7.1.4.1 of IEEE Std. 344·2904) recommends. " that the resonance search be carried beyond 33 Hz. for example, to 50 Hz. or to the RRS cutoff frequency, whichever is higher, to obtain data on equipment dynamic characteristics that may be valuable to justify qualification for other dynamic loads." The required response spectrum used in the testing has a seismic cutoff frequency of about 40 Hz. Furthermore, since the neutron monitoring system equipment described in the LTR is installed near the control room (versus the reactor building), there are no other higher frequency dynamic loads of interest. Accordingly, Toshiba is only concerned with resonances below 50 Hz. Resonance search data was gathered up to 100 Hz based on the test facility standard practice and equipment capabilities.  Three accelerometers for three orthogonal axes were located for the response of the EUT acceleration. Three for front-back, side to side	Figures A.1.1 through A.1.15 shows the results for the resonance search along vertical axis. Figures A.1.1, A.1.6, and A.1.11 are the spectra of the test fixtures. Compared to these spectra other spectra which show the response of the Test Specimen Units and the power line panel do not show major resonance.	III	Detailed descriptions are added.	See DVR-E2-201 70928.

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

sh· 5 / 33

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
			and vertical at the following five locations:  1) the top right corner of the test fixture (EUT were mounted).  2) the right side top center of FLOW Unit chassis.  3) the power module mounting plate.  4) the right side top center of LPRM/APRM Unit chassis.  5) the right side top center of LPRM Unit				
[		Continued	chassis Note) Right/left in above description means right/left when a person faces the front panel of the FLOW.LPRM/APRM, and LPRM Unit			Continued	
			No resonances are identified below 50 Hz on the transmissibility plots. Several resonant peaks are identified above 50 Hz. As discussed above, resonances above the 50 Hz cutoff frequency are not considered consequential. The acceptable seismic test results confirm this conclusion.				
			Resonant peaks are identified in the transmissibility plots at about 75 Hz in the side-to-side (SS) direction and at about 95 Hz in the front-to-back (FB) direction. The results of the transmissibility plots of the test specimens (the Flow unit, the LPRMAPRM				
			unit, and the LPRM unit) can be compared to the transmissibility plot of the test fixture. This comparison shows that the test specimen responses are essentially the same as the test fixture response. Any resonant peaks in the fixture response are mirrored in the test specimen response. Therefore, the test specimens are moving with the fixture and any resonant peaks are a result of the test fixture				\$ .^

the state of the s				
Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.	
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2	

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
		Continued	and not the test specimens. The resonant peaks are sufficiently high and outside the frequency range of interest. Furthermore, examination of the survey accelerometer			Continued	
			response during the seismic tests show that no filtering of test input occurred below the test facility standard practice 100 Hz frequency limit.  Thus. Toshiba evaluates the Test Specimen Units and the power line panel do not show major resonance.				
11	50-52	6.3.2.Data Evaluation (2)Random Multifrequency Tests (5 OBEs and 1 SSE)	Figures in sections A.2.1 to A.2.5 show the TRS for OBE tests and Figures in Section A2.6 show Test Response Spectra for the SSE test. Figures A2.6.4 to A2.6.6 show the coherent plot of the SSE.  Toshiba planned to conduct the seismic test with the RRS provided in Figure 4.5 of EPRI TR:107330 dated October 1997. The TRS listed in figures in Appendix A.2 of the Qualification Test Summarv Report were achievable. Toshiba considers that exceedances below about 3.5 Hz are generally acceptable based on IEEE Std. 344 2004 Section 8.6.3.1(p) since there are clearly no resonances below 5 Hz. Toshiba evaluated the higher frequency area. Toshiba found that Figure 4.5 of a later version of EPRI TR:107330 is slightly different from Figure 4.5 in the original October 1997 version which is the basis for the current Toshiba RRS. Toshiba evaluated the difference. The later version (available from the EPRI website) provides Figure 4.5 with a narrow peak spectral band. Specifically, the 5% damped SSE response	Figures in sections A.2.1 to A.2.5 show the TRS for OBE tests and Figures in Section A2.6 show Test Response Spectra for the SSE test. Figures A2.6.4 to A2.6.6 show the coherent plot of the SSE.  These test results show that the random multi frequency tests conditions were successfully applied to the Test Specimen Units with the single exception of not meeting the peak loading for the SSE, based on table limits.	Ш	Detailed descriptions and a figure are added.	See DVR-E2-201 70928.

Job No. DCN No. DCN No. DCN-FPG-TRT-C51-0101-002 Rev. No. Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

sh· 7 / 33

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
			spectrum control points of Figure 4-5 of the later version of EPRI TR-107330 are (1 Hz. 0.42 g): (4.5 Hz. 14 g): (16 Hz. 14 g): (33 Hz.6.13 g). and (100 Hz. 6.13 g). The original version of Figure 4-5 includes a broader frequency. Specifically. the 5 % damped SSE response spectrum break points of this version of Figure 4-5 are (0.5 Hz. 0.1 g): (1 Hz. 0.8 g): (3 Hz. 14 g): (33 Hz. 14 g): (40 Hz. 7 g): and (100 Hz. 7 g). The discussion here refers to the version of EPRI TR-107330 Figure 4-5 of the later version of EPRI TR-107330 as the "narrow" spectrum. and the other version of EPRI TR-107330 Figure 4-5 as the "broad"				
		Continued	spectrum.  Because of test table limitation of 9.8 g. Toshiba has had to take exception to the EPRI TR-107330 requirement of 14 g in the PRM testing. The PRM testing was conducted at a			Continued	
			laboratory where the table could not satisfy the EPRI TR-107330 peak spectral limits. Specifically, the table could only satisfy a peak spectral demand of 9.8 g. PRM test results show that the "narrow" spectrum demand is satisfied with the following exceptions.  The 14 g peak in the narrow spectrum was above the table capacity. The table capacity produced a peak that exceeded 9.8 g.  Exceedances in the frequency lower than 3.5 Hz are acceptable based on Clause 8.6.3.1(j) of IEEE Std. 344-2004 since there are clearly no resonances below 5 Hz.  An additional exception to the "broad" EPRI TR-107330 spectrum				

Job No. DCN No. DCN-FPG-TRT-C51-0101-002 Rev. No. Doc. Title, No. and Rev. No. Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

sh· 8 / 33

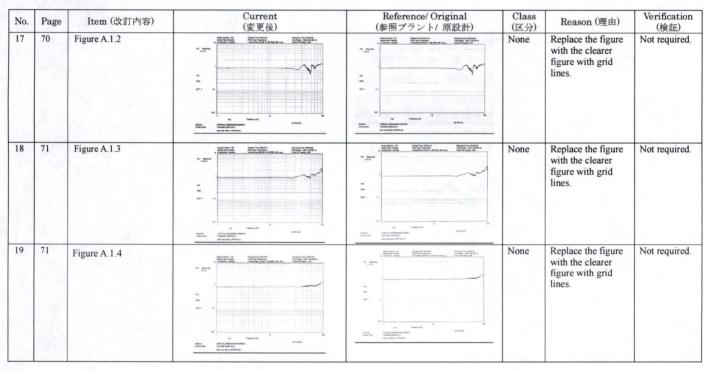
No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
			demand would have to be taken for the exceedance at the peak above 30 Hz.  Figure 6.3.1 shows the qualified SSE response of the PRM seismic test.				
		Continued				Continued	
			Figure 6.3.1 Qualified SSE for PRM				
12	56	6.4.2.1 EMI/RFI Emission Test	From 100 Hz to approximately 1200 Hz, the emission exceeded the limit shown in RG1.180R1.	From 100 Hz to 700 Hz, the emission exceeded the limit shown in RG1.180R1.	Ш	Data evaluation correction.	See DVR-E2-201 70928.
13	59	6.4.2.3 Surge Withstand Capability Test	'[Line and Neutral] and Ground, only for Ring Wave*  *Note: IEC 61000-4-5 (for Combination Wave) does not require the test for '[Line and Neutral] and Ground." Only Edition 1 (1995) of IEC 61000-4-12 (for Ring Wave) required the test for "[Line and Neutral] and Ground." while later Editions of the same standard do not	·[Line and Neutral] and Ground, only for Ring Wave	Ш	Supplemental descriptions are added	See DVR-E2-201 70928.
14	60	6.4.2.3.Surge Withstand Capability Test	The surges were applied to the test points shown in Tables B10.1 and B10.2. The Test Specimen Units operated normally before,	The surges were applied to the test points shown in Tables B10.1 and B10.2. The Test Specimen Units operated normally	III	Detailed descriptions are	See DVR-E2-201
Job N FPG		DCN No. DCN-FPG-TRT-C51-0	Rev. No. Doc. Title, No. ar 101-002 0 Qualification T	nd Rev. No. Test Summary Report, FPG-TRT-C	51-0101	Rev.2 sh	- 9 / 33

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
			during, and after testing.  Toshiba and the Test Lab cannot find the record of the impedance value used. R.G. 1.180 Revision 1 does not specify the impedance. and references IEEE Std. C62.41·1991. IEEE Std. C62.41 specifies 12 Q. for the Category B Location. Toshiba conducted	before, during, and after testing.		added	70928.
Г		01	the IEC 61000-4-12 test at Low Exposure for a Category B Location: therefore the impedance was likely 12 Ω. A HAEFLEY PIM 110 was used for the surge test and the factory default				
		Continued	impedance is 12 $\Omega$ . The test was intended to be performed at 12 $\Omega$ , but Toshiba and the Test Lab cannot confirm the actual setting used. Test results show that the specimen passed the short circuit test that was performed. This leaves two possibilities. First, the test was actually performed at the 12 $\Omega$ setting, and there is no issue. This is the default setting of the test equipment and the most likely scenario. However, there is still a possibility that the test was performed with 30 $\Omega$ . For this case, the test results are not confirmed against 12 $\Omega$ for Category B location test that brings more			Continued	
			energy to the test specimen.  Toshiba considers that it should be assumed that 30 \( \Omega\) was applied for the test to take conservative position for the appropriate evaluation in a situation where the impedance value cannot be confirmed. Toshiba considers that the assumption of 30 \( \Omega\) is appropriate, because the PRM is designed to be connected to the end of the power supply system in nuclear power plants. Therefore, Toshiba assumes either impedance is workable, and				

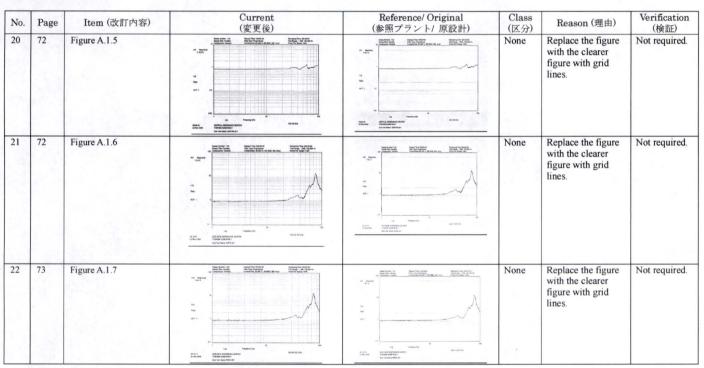
Job No.	DCN No.	Rev. No.	Doc. Title. No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
			that the higher impedance would not impact the surge withstand capabilities of the PRM.				
15	61-62	6.4.2.5.ESD Test	Temporary degradation or recoverable loss of function were identified when the ESD transients were applied to the rear panels, or the parts placed on these panels, which will not be exposed to ESD during normal operation. There is no reason for an operator to access the rear panels. Technicians accessing the rear panels will do so under work order, with the equipment bypassed. The work order will specify that grounded wrist straps are required. The back panels in the units are accessible only when locked cabinet doors are opened. Thus, the back panels are not normally exposed to ESD.	Temporary degradation or recoverable loss of function were identified when the ESD transients were applied to the rear panels, or the parts placed on these panels, which will not likely be exposed to ESD during normal operation.	None	Additional descriptions are added	Not required.
16	70	Figure A.1.1	The second secon	Section   Sect	None	Replace the figure with the clearer figure with grid lines.	Not required.

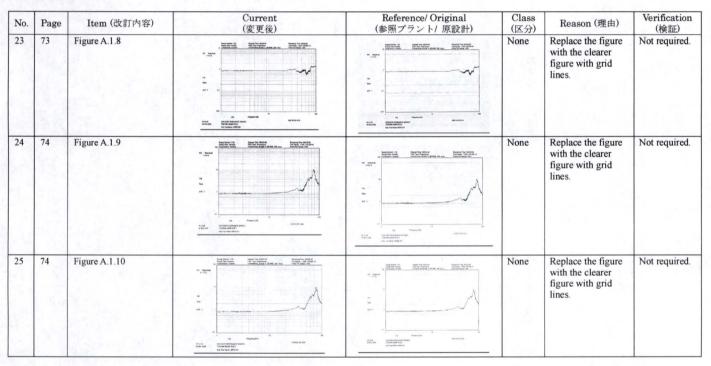
Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2



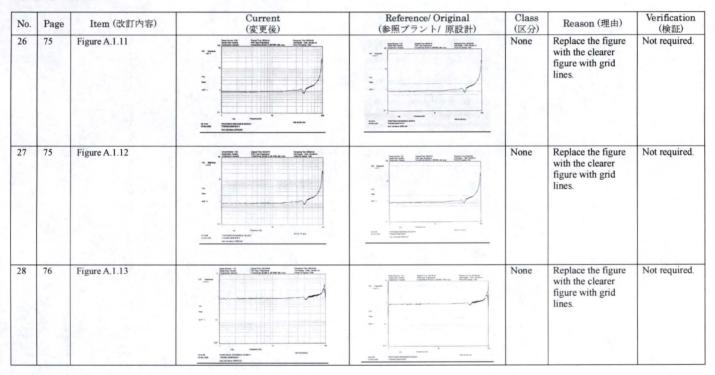
Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2



Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2



Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.	
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2	

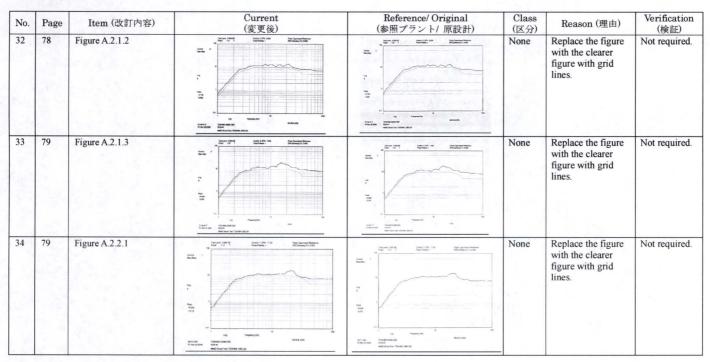


Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

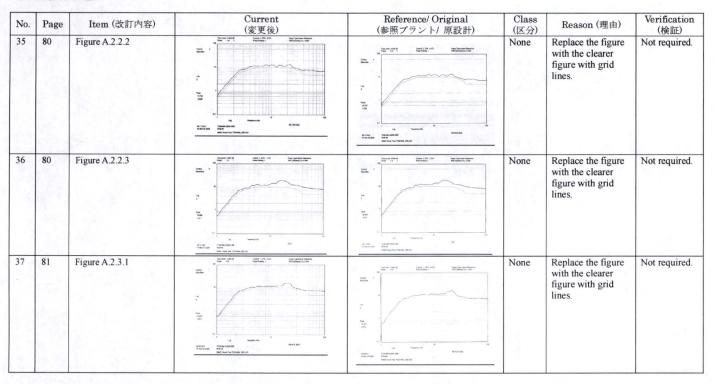
No.			Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
29	76	Figure A.1.14	The second secon	The second secon	None	Replace the figure with the clearer figure with grid lines.	Not required.
30	77	Figure A.1.15	Figure A.1.15 LPRM Unit's spectrum for Horizontal (East to West) vibration	Figure A.1.14 LPRM Unit's spectrum for Horizontal (East to West) vibration	None	Replace the figure with the clearer figure with grid lines. Error correction.	Not required.
31	78	Figure A.2.1.1	Secretary of the secret	The state of the s	None	Replace the figure with the clearer figure with grid lines.	Not required.

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

sh· 16 / 33

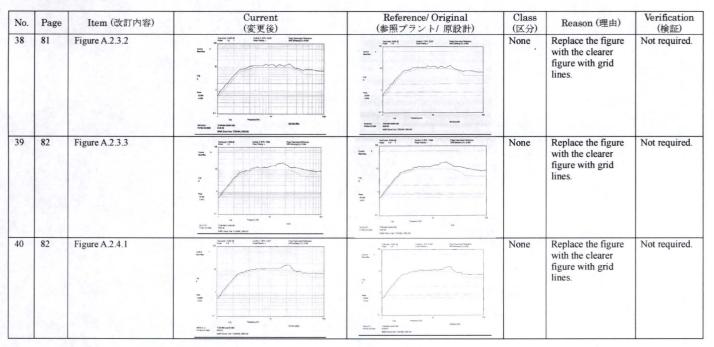


Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

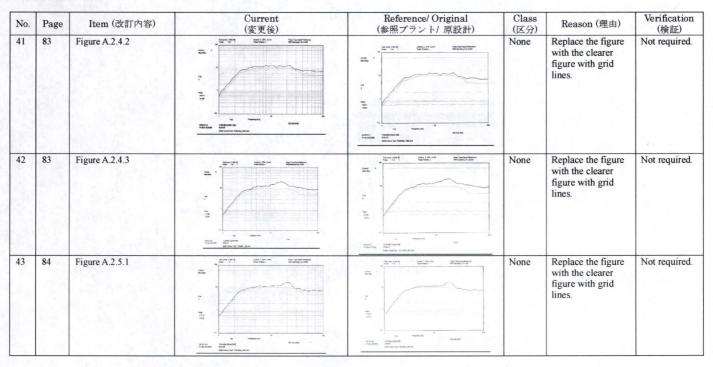


Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
W. C. C. C. C. C.	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

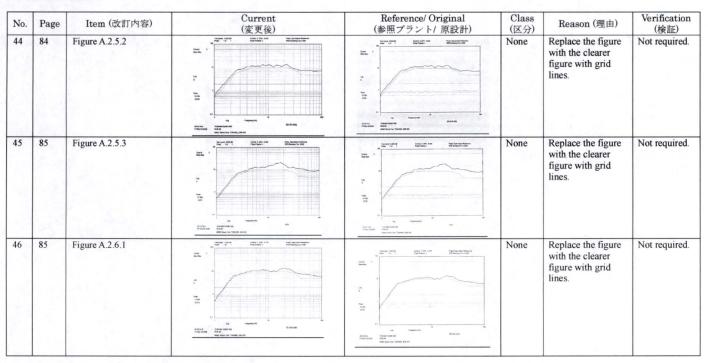
sh· 18 / 33



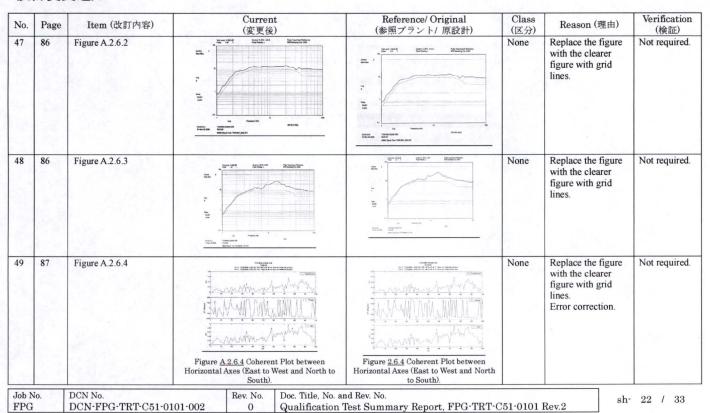
Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.	
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2	



Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

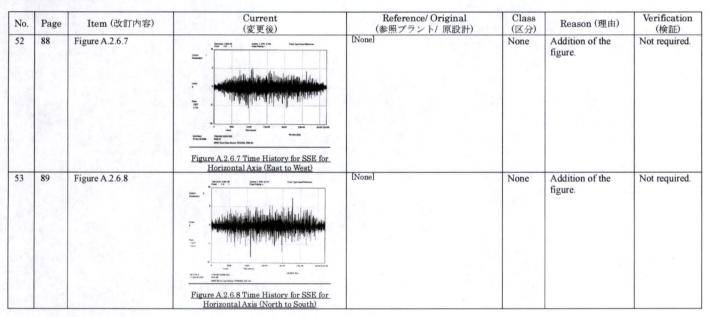


Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2



No.	Page	(変更後)		Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
50	87	Figure A.2.6.5		M. M	None	Replace the figure with the clearer figure with grid lines.	Not required.
			Figure <u>A.</u> 2.6.5 Coherent Plot for Horizontal Axis (East to West) and Vertical Axis.	Figure 2.6.5 Coherent Plot for Horizontal Axis (East to West) and Vertical Axis.		1.58	
51	88	Figure A.2.6.6			None	Replace the figure with the clearer figure with grid lines.	Not required.
			Figure A.2.6.6 Coherent Plot for Horizontal Axis (North to South) and Vertical Axis.	Figure 2.6.6 Coherent Plot for Horizontal Axis (North to South) and Vertical Axis.			

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2



Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
54	89	Figure A.2.6.9	Figure A.2.6.9 Time History for SSE for Vertical Axis	[None]	None	Addition of the figure.	Not required.
55	90	Figure A.2.6.10	Figure A.2.6.10 Time interval PSD coherence plot for SSE for Horizontal Axis (East to West)	None None		Addition of the figure.	Not required.
56	90	Figure A.2.6.11	Figure A.2.6.11 Time interval PSD coherence plot for SSE for Horizontal Axis (North to South)	[None]	None	Addition of the figure.	Not required.
Job N FPG	2000	DCN No. DCN-FPG-TRT-C51-0	Rev. No. Doc. Title, No. as	nd Rev. No. Test Summary Report, FPG-TR7	Γ-C51-0101	Rev.2 sh	- 25 / 33

No.	Page	Item (改訂内容)		urrent E更後)	Reference/ Original (参照プラント/ 原設計)		Class (区分)	Reason (理由)	Verification (検証)
57	91	Figure A.2.6.12	Figure 2.6.12 Time	interval PSD coherence	[None]		None	Addition of the figure.	Not required.
58	98	Table B.3.1	Ted Point Cable#10 (Inve) Cabl	Complant will Specification This departmentary TOTAL to approximate 1000-16. No departmentary TOTAL to approximate 1000-16. No departmentary TOTAL to approximate 1000-16. No department of the level of approximate 1000-16. No Yea Yea Yea Yea Yea Yea	See Price Collection Course Collection Course Collection Collectio	Computer with Equations of the Computer with Equations of the Computer with Equation of the Computer with the Computer w	Ш	Data evaluation correction.	See DVR-E2-201 70928.
59	98	Table B.3.2	Presente (c)   President (c)   CETTS LES     Presente (c)   President (c)   CETTS LES     Presente (c)   Presente (c)     Pres	A) (diff recor A) (of this way A) (Section 1.1)  12.2 0.0 (Section 1.1)  111.2 0.0 (Section 1.1)  111.2 0.0 (Section 1.1)  102.2 1.2 1.3 Mo.  100.7 12.7 Mo.  100.7 12.7 Mo.  100.3 1.7 Mo.  100.3 1.7 Mo.  100.3 1.7 Mo.  100.5 1.7 Mo.	Precision   Press Anglesia   Colon 112   (90 ) (80 mays A)   Press Anglesia   Colon 112   (80.809 ) (12.9 ) 1132   (100.414 ) (100.11 ) (100.11 ) (100.11   (100.414 ) (100.11 ) (100.11 ) (100.11   (100.414 ) (100.11 ) (100.11   (100.414 ) (100.11 ) (100.11   (100.414 ) (100.11 ) (100.11   (100.414 ) (100.11 ) (100.11   (100.414 ) (100.11   (10		Ш	Clarification of description and data evaluation correction.	See DVR-E2-201 70928.

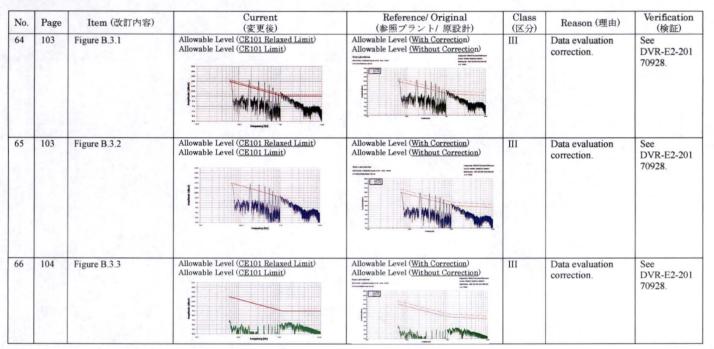
Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

No.	Page	Item (改訂内容)			irrent (更後)						ce/ Origin ント/ 原語		Class (区分)	Reason (理由)	Verification (検証)
60	99	Table B.3.3		Certiff Limited A. Certiff Limited A. Certiff Limited A. Lind Line Line Line Line Line Line Line Line	GE101 Retained Limit. (ett micro A) 172.5 122.5	Margin (d8 micro A)  0.0  19.1  19.1  24.2  51.9  51.9  51.9  52.9  52.9  14.9	Complant Special Compla	Frequency 640 60 764 14 160 14 160 17 164 17 164 17 164 18 166 18 166	Fresh (**) Service	Citi tues (de misro A) (de misro A) (de misro A) (de misro A) (177.8 to 177.8 to 177.8 to 177.8 to 177.9 to 177.8 to 177.9 to 177.8 to 177.9 to 177	GESS Lens. General and St. 2014. General and	Description   Correlate   Co	Ш	Clarification of description and data evaluation correction.	See DVR-E2-201 70928.
61	100	Table B.3.4	Mergin - Presh Austin - Presh Sangle	CE101 Limit Multiple CE101 Lim	CE101 Retend Liest (dB entre A) 112.7 112.7 111.8 100.6 100.5 100.5 100.5 100.5 100.5 100.7 110.9 111.	Margin (dB minn A) 92	Complant with Specification Specification Fire Fire Fire Fire Fire Fire Fire Fire	Frequency (+0 to 2) (-0 to 3) (-0 to	Piesk AmpRitude (db minor A) 122.7 111.3 101.5 94.3 97.9 97.9 97.9 97.9 97.9 97.9 97.9 97	CE101 Lines Plantoniminal (december 2) 1118 9 1001 8 1001 7 1002 9 17 7 1502 9 17 7 1502 1112 5 1112 5 1112 1113 1117 7 116.0	Of 10 Live Commission 5.034 (Commission 5.034 (C	Neign   Cornidard   Cornidar	Ш	Clarification of description and data evaluation correction.	See DVR-E2-201 70928.

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

No.	Page	Item (改訂内容)		Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
62	101	Table B.3.5	Presidency   Pre	100   100	Presented   Present	Ш	Clarification of description and data evaluation correction.	See DVR-E2-201 70928.
63	103	Table B.3.6		Control   Cont	Projection   New Arginitude	Ш	Clarification of description and data evaluation correction.	See DVR-E2-201 70928.

	Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
3	FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2



Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
67	104	Figure B.3.4	Allowable Level (CE101 Relaxed Limit) Allowable Level (CE101 Limit)	Allowable Level (With Correction) Allowable Level (Without Correction)	Ш	Data evaluation correction.	See DVR-E2-201 70928.
68	105	Figure B.3.5	Allowable Level (CE101 Relaxed Limit) Allowable Level (CE101 Limit)	Allowable Level (With Correction) Allowable Level (Without Correction)	Ш	Data evaluation correction.	See DVR-E2-201 70928.
69	105	Figure B.3.6	Allowable Level (CE101 Relaxed Limit) Allowable Level (CE101 Limit)	Allowable Level (With Correction) Allowable Level (Without Correction)	Ш	Data evaluation correction.	See DVR-E2-201 70928.

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
70	106	Figure B.3.7	Allowable Level (CE101 Relaxed Limit) Allowable Level (CE101 Limit)	Allowable Level (With Correction) Allowable Level (Without Correction)	Ш	Data evaluation correction.	See DVR-E2-201 70928.
71	106	Figure B.3.8	Allowable Level (CE101 Relaxed Limit) Allowable Level (CE101 Limit)	Allowable Level (With Correction) Allowable Level (Without Correction)	Ш	Data evaluation correction.	See DVR-E2-201 70928.
72	107	Figure B.3.9	Allowable Level (CE101 Relaxed Limit) Allowable Level (CE101 Limit)	Allowable Level (With Correction) Allowable Level (Without Correction)	Ш	Data evaluation correction.	See DVR-E2-201 70928.
73	118	Table B10.1	Note: The ring wave test was expected to be performed with $12\Omega$ coupling impedance. This is the default setting of the test equipment and the most likely scenario. However, this is not described in the record and it cannot be reconfirmed that the test was performed with $12\Omega$ not $30\Omega$ . If the possibility that the test was performed with $30\Omega$ cannot be fully denied, in this possibility, the test results are	[None]	Ш	Detailed description added.	See DVR-E2-201 70928.

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

sh· 31 / 33

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
			not confirmed against 12 Ω that brings more energy to the test specimen. Toshiba considers that it should be assumed that 30 Ω was applied for the test to take conservative position for the appropriate evaluation in a				
		Continued	situation where the impedance value cannot be confirmed. Toshiba considers that the			Continued	
			assumption of 30 $\Omega$ is appropriate, because the PRM is designed to be connected to the end of the power supply system in nuclear power plants. Therefore, Toshiba assumes either impedance is workable, and that the higher impedance would not impact the surge withstand capabilities of the PRM.				
74	118	Table B10.2	That Politics To See The Comment Operation Complete and Comment To See The Comment To See	The Prints Not Open than O	III	Error correction	See DVR-E2-201 70928.
75	129	Table B13.1	Between pin L and pin R of the output connector bf HNS518 AO module installed in BSL1 of FLOW Unit  Between pin L and pin R of the output connector bf HNS516 AO module installed in BSL2 of FLOW Unit  Between pin L and pin R of the output connector bf HNS517 AO module installed in BSL3 of FLOW Unit	Between pin JJ and pin PP of the output connector of HNS518 AO module installed in BSL1 of LPRM/APRM Unit  Between pin JJ and pin PP of the output connector of HNS516 AO module installed in BSL2 of LPRM/APRM Unit  Between pin A and pin E of the output connector of hf HNS515 AO module installed in BSL3 of LPRM/APRM Unit	None	Editorial error correction.	Not required.

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2

No.	Page	Item (改訂内容)	Current (変更後)	Reference/ Original (参照プラント/ 原設計)	Class (区分)	Reason (理由)	Verification (検証)
76	130	Table B13.2	Between pin L and pin R of the output connector of HNS518 AO module installed in BSL1 of FLOW Unit  Between pin L and pin R of the output connector of bf HNS516 AO module installed in BSL2 of FLOW Unit  Between pin L and pin R of the output connector of bf HNS517 AO module installed in BSL3 of FLOW Unit	Between pin JJ and pin PP of the output connector   Df HNS518 AO module installed in BSL1 of LPRM/APRM Unit  Between pin JJ and pin PP of the output connector   Df HNS516 AO module installed in BSL2 of LPRM/APRM Unit  Between pin A and pin E of the output connector   Df HNS515 AO module installed in BSL3 of LPRM/APRM Unit	None	Editorial error correction.	Not required.

Job No.	DCN No.	Rev. No.	Doc. Title, No. and Rev. No.
FPG	DCN-FPG-TRT-C51-0101-002	0	Qualification Test Summary Report, FPG-TRT-C51-0101 Rev.2